

**Search Notes**

Application/Control No.

10/054,839

Examiner

Djenane M. Bayard

Applicant(s)/Patent under  
Reexamination

PARKMAN ET AL.

Art Unit

2141

**SEARCHED**

Class	Subclass	Date	Examiner
707	10	2/6/2006	DB
725	76	2/6/2006	DB
709	238	2/6/2006	DB
725	75	2/6/2006	DB

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
east	2/6/2006	DB